

MOSFET, N-Channel, POWERTRENCH®

40 V, 18.6 A, 4.5 m Ω

FDS8840NZ

General Description

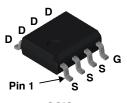
The FDS8840NZ has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance.

Features

- Max $r_{DS(on)} = 4.5 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 18.6 \text{ A}$
- Max $r_{DS(on)} = 6.0 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 14.9 \text{ A}$
- HBM ESD Protection Level of 6 kV Typical (Note 3)
- High Performance Trench Technology for Extremely Low $r_{DS(on)}$ and Fast Switching
- High Power and Current Handling Capability
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

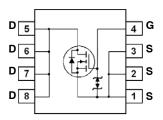
Applications

- Synchronous Buck for Vcore and Server
- Notebook Battery Pack
- Load Switch

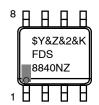


SOIC8 CASE 751EB

PIN ASSIGNMENT



MARKING DIAGRAM



= **onsemi** Logo

\$Y

&Z = Assembly Plant Code &2 = Numeric Date Code

&K = Lot Code

FDS8840NZ = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

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ORDERING INFORMATION

Part Number	Device Marking	Package	Shipping [†]
FDS8840NZ	FDS8840NZ	SOIC8 (Pb-Free / Halogen Free)	2500 Units / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Value	Unit
V _{DS}	Drain to Source Voltage	40	V
V_{GS}	V _{GS} Gate to Source Voltage		V
I _D	Drain Current Continuous	18.6	Α
	Drain Current Pulsed	63	
E _{AS}	Single Pulse Avalanche Energy (Note 4)	600	mJ
P_{D}	Power Dissipation, T _A = 25°C (Note 1a)	2.5	W
	Power Dissipation, T _A = 25°C (Note 1b)	1.0	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit	
$R_{ hetaJC}$	Thermal Resistance, Junction to Case (Note 1)	25	°C/W	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	°C/W	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions Mir		Тур	Max	Unit
Off Charac	teristics	•				
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V
$\Delta BV_{DSS} \ \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C 31			mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 32 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ
On Charac	teristics			-		
VGS(th)	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0 1		3.0	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-6			mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 18.6 A		3.9	4.5	mΩ
		V _{GS} = 4.5 V, I _D = 14.9 A		4.6	6.0	
		V _{GS} = 10 V, I _D = 18.6 A, T _J = 125°C		5.9	7.0	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 18.6 A		83		S
Dynamic C	haracteristics					
Ciss	Input Capacitance	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		5665	7535	pF
Coss	Output Capacitance]		650	865	pF
Crss	Reverse Transfer Capacitance	1		445	670	pF
R_g	Gate Resistance			1.2		Ω

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
Switching	Characteristics			•	•	•	
td(on)	Turn-On Delay Time	$V_{DD} = 20 \text{ V}, I_{D} = 18.6 \text{ A}, V_{GS} = 10 \text{ V},$ $R_{GEN} = 6 \Omega$			18	32	ns
t _r	Rise Time				13	23	ns
td(off)	Turn-Off Delay Time				57	103	ns
t _f	Fall Time				11	20	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	V _{DD} = 20 V,		103	144	nC
Q_g	Total Gate Charge	V _{GS} = 0 V to 5 V	I _D = 18.6 A		54	76	nC
Qgs	Gate to Source Charge				16		nC
Qgd	Gate to Drain "Miller" Charge				19		nC
Drain-Sou	rce Diode Characteristics						
VsD	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 18.6 A			0.8	1.2	V
		V _{GS} = 0 V, I _S = 2.1 A			0.7	1.2	1
trr	Reverse Recovery Time	I _F = 18.6 A, di/dt = 100 A/μs			33	53	ns
Qrr	Reverse Recovery Charge				21	34	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a.) 50°C/W when mounted on a 1 in² pad of 2 oz copper



b.) 125°C/W when mounted on a minimum pad

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. The diode connected between the gate and source servers only as protection against ESD. No gate overvoltage rating is implied. 4. Starting $T_J = 25$ °C, L = 3 mH, $I_{AS} = 20$ A, $V_{DD} = 40$ V, $V_{GS} = 10$ V.

TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)

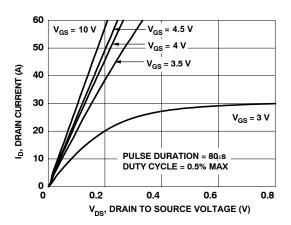


Figure 1. On-Region Characteristics

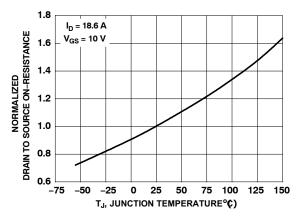


Figure 3. Normalized On–Resistance vs Junction Temperature

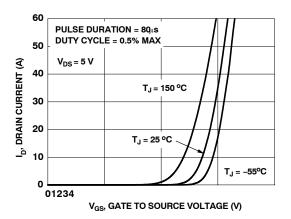


Figure 5. Transfer Characteristics

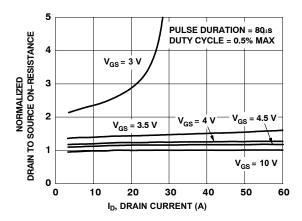


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

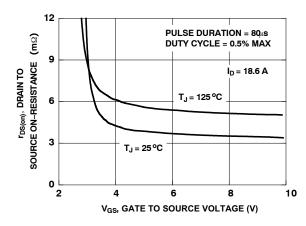


Figure 4. On-Resistance vs Gate to Source Voltage

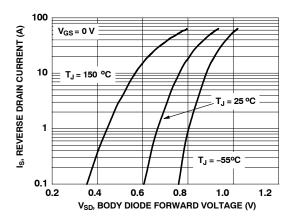


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

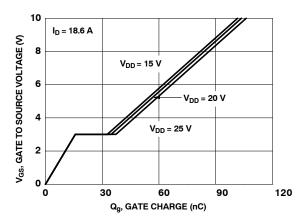


Figure 7. Gate Charge Characteristics

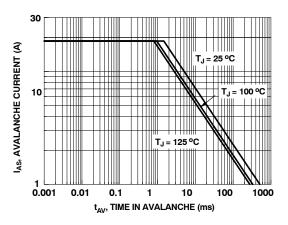


Figure 9. Unclamped Inductive Switching Capability

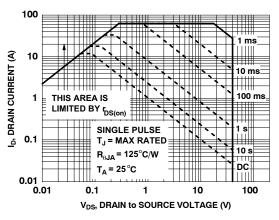


Figure 11. Forward Bias Safe Operating Area

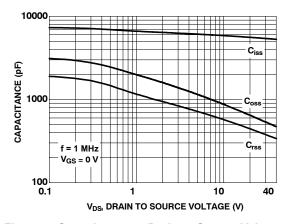


Figure 8. Capacitance vs Drain to Source Voltage

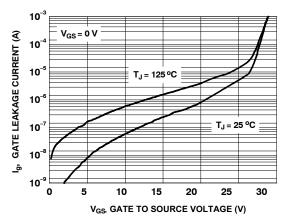


Figure 10. I_{GSS} vs V_{GS}

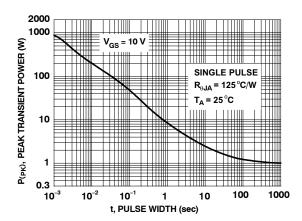


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

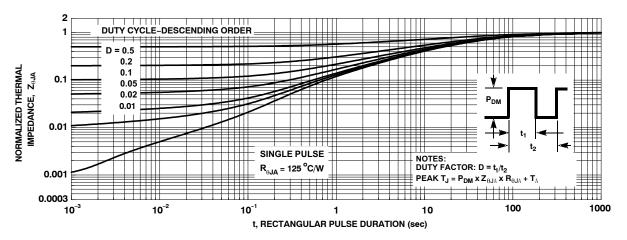


Figure 13. Transient Thermal Response Curve

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CASE 751EB **ISSUE A DATE 24 AUG 2017** ·4.90±0.10 → -0.65(0.635)В 6.00±0.20 5.60 3.90±0.10 PIN ONE **INDICATOR** 1.27 1.27 0.25(M) LAND PATTERN RECOMMENDATION В SEE DETAIL A 0.175±0.075 0.22±0.03 С 1.75 MAX 0.10 0.42±0.09 OPTION A - BEVEL EDGE $(0.43) \times 45^{\circ}$ R0.10 GAGE PLANE OPTION B - NO BEVEL EDGE R0.10-0.25 NOTES: A) THIS PACKAGE CONFORMS TO JEDEC MS-012, VARIATION AA. B) ALL DIMENSIONS ARE IN MILLIMETERS. **SEATING PLANE** C) DIMENSIONS DO NOT INCLUDE MOLD 0.65±0.25 FLASH OR BURRS. D) LANDPATTERN STANDARD: SOIC127P600X175-8M (1.04)**DETAIL** À SCALE: 2:1 Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DOCUMENT NUMBER:** 98AON13735G

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DESCRIPTION:

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